

Issue Classification		Application/Control No.	Applicant(s)/Patent under Reexamination	
		09/759,677	CHEN ET AL.	
		Examiner	Art Unit	
		Curtis B. Odom	2634	

ORIGINAL			CROSS REFERENCE(S)					
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
375	132							
INTERNATIONAL CLASSIFICATION								
H 04 B	1169							
H 04 B	11707							
H 04 B	11713							
	1							
	1							
<i>Curtis Odom 1/4/06</i> (Assistant Examiner) (Date)			<i>Chieh M. Fan</i> CHIEH M. FAN SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date) <i>1/10/06</i> 119106			Total Claims Allowed: 76		
<i>Z. M. F.</i> (Legal Instruments Examiner) (Date)						O.G. Print Claim(s)	O.G. Print Fig.	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R. 1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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3	5	48	35	69	65	95	125
4	6	64	36	70	66	96	126
5	7	37	37	71	67	97	127
6	8	38	38	72	68	98	128
7	9	39	39	73	69	99	129
8	10	40	40	74	70	100	130
9	11	41	41	75	71	101	131
10	12	42	42	76	72	102	132
11	13	43	43	77	73	103	133
14	14	44	44	78	74	104	134
15	15	45		79	75	105	135
16	16	46		80	76	106	136
17	17	47		81	77	107	137
18	18	50	48	82	78	108	138
19	19	51	49	83	79	109	139
20	20	52	50	84	80	110	140
21	21	53	51	85	81	111	141
22	22	54	52	86	82	112	142
23	23	55	53	87	83	113	143
24	24	56	54	88	84	114	144
25	25	57	55	89	85	115	145
26	26	58	56	90	86	116	146
27	27	59	57	91	87	117	147
30	28	60	58	92	88	118	148
31	29	61	59	93	89	119	149
32	30	62	60	94	90	120	150